


FORM PTO-1449		ATTY. DKT NO. 11-208	SER. NO. 10/725,269
		APPLICANT SAMUKAWA et al.	
		FILING DATE December 2, 2003	GROUP 3662

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

## FOREIGN PATENT DOCUMENTS

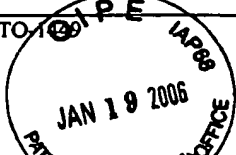
## TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract

\* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

TC	Decision of Refusal from Japanese Patent Office issued on April 11 2006 for the corresponding Japanese patent application No. 2002-354216 (a copy and English translation thereof)
EXAMINER TUAN C TO	DATE CONSIDERED 06/13/06

FORM PTO-101 	ATTY. DKT NO. 11-208	SER. NO. 10/725,269
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## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

TC	Notification of Reasons for Rejection issued from Japanese Patent Office issued on December 6, 2005 for the corresponding Japanese patent application No. 2002-354216 (a copy and English translation thereof)	
EXAMINER	TUAN C TO	DATE CONSIDERED 06/13/06

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
TC	US 6,018,308 (English counterpart to JP-A-H11-38142)	1/25/00	SHIRAI		

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract

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## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	THAN C TO	DATE CONSIDERED	06/13/06
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Form PTO-1449  <b>PATENT AND TRADEMARK OFFICE</b> <b>INFORMATION DISCLOSURE CITATION</b> (Use several sheets if necessary)  Sheet 1 of 1	ATTORNEY DOCKET NO. <div style="text-align: center; font-size: 1.2em;">11-208</div>	SERIAL NO. <div style="text-align: center; font-size: 1.2em;">10/725, 269</div>
	APPLICANT <div style="text-align: center;">Yoshie SAMUKAWA et al.</div>	
	FILING DATE <div style="text-align: center; font-size: 1.2em;">December 2, 2003</div>	GROUP <div style="text-align: center; font-size: 1.2em;">3663</div>

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
	TC	5,805,527	9/8/98	Hoashi et al. (corres. to JP9-236661)	—	
	TC	6,593,873	7/15/03	Samukawa et al. (corres. to JP2002-40137)	—	

FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation	
						Yes	No
	TC	9-236661	9/9/97	Japan	—		
	↑	11-38141 (Discussed on page 4 in spec.)	2/12/99	Japan	—	X	
		2002-22827 (Discussed on page 5 in spec.)	1/23/02	Japan	—	X	
		2002-40139 (Discussed on page 1 in spec.)	2/6/02	Japan	—	X	
		2002-40137	2/6/02	Japan	—		
	TC	2002-131433	5/9/02	Japan	—	X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	

EXAMINER: <i>TUAN C TO</i>	Date Considered: <i>06/13/06</i>
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EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

• PATENT APPLICATION  
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REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
TC	US 6,900,754 (corresp. to the JP-A-2002-341021 and JP-A-2002-341020)	05/31/05	Ono et al.		
	US 2003/0142007 (corresp. to the JP-A-2002-341021 and JP-A-2002-341020)	07/31/03	Ono et al.		
	US 6,249,243 (corresp. to the JP-A-2000-180540)	06/19/01	Takagi		
	US 6,753,805 (corresp. to the JP-A-2003-185738)	06/22/04	Nakanishi et al.		
TC	US 6,661,370 (corresp. to the JP-A-2003-177178)	12/09/03	Kishida et al.		

FOREIGN PATENT DOCUMENTS

TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
								Eng. Abstract	
TC	JP-A-2002-341021 (corresp. to the US 6,900,754 and US 2003/0142007)	11/27/02	JAPAN					X	
	JP-A-2002-341020 (corresp. to the US 6,900,754 and US 2003/0142007)	11/27/02	JAPAN					X	
	JP-A-2001-183462	07/06/01	JAPAN						X
	JP-A-2002-014165	01/18/02	JAPAN						X
	JP-A-2002-099907	04/05/02	JAPAN						X
	JP-A-2000-180540 (corresp. to the US 6,249,243)	06/30/00	JAPAN					X	
	JP-A-2003-185738 (corresp. to the US 6,753,805)	07/03/03	JAPAN					X	
TC	JP-A-2003-177178 (corresp. to the US 6,661,370)	06/27/03	JAPAN					X	

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	FILING DATE	December 2, 2003	GROUP	3662

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
TC	5,798,727 (counterpart of JP-A-H09-178848)	08/25/98	Shirai et al.		

FOREIGN PATENT DOCUMENTS

TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
									Eng. Abstract	
	TC	JP-A-S61020877	01/29/86	JAPAN						X
		JP-A-2002-122669	04/26/02	JAPAN						X
		JP-A-2002-006040	01/09/02	JAPAN						X
		JP-A-H11-038142	02/12/99	JAPAN					X	
		JP-A-H09-178848 (counterpart of US 5,798,727)	07/11/97	JAPAN						
		JP-A-H06-109842	04/22/94	JAPAN						X
		JP-A-H07-191143	07/28/95	JAPAN						X
		JP-A-H06-109841	04/22/94	JAPAN						X
	TC	JP-A-UM-H03-121399	12/12/91	JAPAN				Spot transl.		

- Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

TC	Two (2) Office Communications from JP Patent Office dated June 28, 2005.
EXAMINER	DATE CONSIDERED
THAN C TO	06/13/06